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	FORM PTO 1449)	ATTY, DKT, NO.:	US-152O	APP. NO.: 10/613	
INFORM	MATION DISCLOSURE	STATEMEN	APPLICANT(S): 1s	shikawa et al.		
			FILING DATE: Ju	ly 8, 2003	Group Art Unit: 1	632
;		·	S. PATENT DOCUMEN	TS		
EXAMINER INITIAL	DOCUMENT NUMBER	PUB'N DATE	NAME	CLASS	SUB-CLASS	FILING DATE
yV	US2004/0152174	5 Aug. 2004	Cervin et al.	435	106	6 Oct. 2003
EXAMINER	DOCUMENT	FOR DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION
INITIAL	NUMBER					☐Yes ☐ No
						□Yes □ No
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	FORM PTO 14	49		ATTY. DKT. NO.:	US-152O	APP. NO.: 10/61.	
INFOR	MATION DISCLOSUE	RE STATEMEN]	[APPLICANT(S): Is	shikawa et al.		
		•		FILING DATE: Jul	y 8, 2003	Group Art Unit: 1	636
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EXAMINER INITIAL	DOCUMENT NUMBER	PUB'N DATE		NAME	CLASS	SUB-CLASS	FILING DATE
M,	US2004/0152174	Aug. 5, 2004	Ce	rvin et al.	435	106	Oct. 6, 2003
AN	10/701.923	n/a	Ta	kikawa et al.			Nov. 6, 2003
M	6,040,160	Mar.21, 2000	Ko	iima et al.			May 29, 1996
AN	-09/307.45 0	n/a	Ko	jima et al.			May 10, 1999
AND.	09/495.310	n/a	Ко	ilma et al.			Feb. 1, 2000
AN	10/868,338	o/a	Kanno et al.				Jun. 18, 2001
ANN	10/149,450	n/a	Nakanishi et ai.				Jun. 27, 2002
M	US2002/0155556	Oct. 24, 2002	Imaizumi et al.		435	115	Dec. 21, 2001
NIL	10/862,424	n/a	lm	aizumi et al.			Jun. 8, 2004
NN	US2004/0229305	Nov.18, 2004	Us	uda et al.	435	69.1	May 16, 2003
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FORM PTO 1449 INFORMATION DISCLOSURE STATEMENT				ATTY. DKT. NO.: US-1520		20	APP. NO.: 10/613,990	
				APPLICANT(S): Ishikawa et al.				
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			FILING DATE:	July 8, 2003	Group Art Unit:	1632
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W	Search Report from EPO	Nov. 13, 2003	EPO			□Yes □ No
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<u>~~/</u>	Cotter et al., "Contribution	Including Aut of the far an	thor, Title, Date, Pertine	ent Pages, Publis	her, etc.)	ne o and d oxidase
M	(cyoABCDE and cydAB)	genes in Esch	nerichia coli" FEMS Mic	cro. Lett., 91:31-	-36 (1992)	
M	luchi et al., "arcA (dyc), a global regulatory gene in Escherichia coli mediating repression of enzymes in aerobic pathways" Proc. Natl. Acad. Sci. USA, 85:1888-1892 (1988)					
m.	Nystrom et al., "Bacterial defense against aging: role of the Escherichia coli ArcA regulator in gene expression, readjusted energy flux and survival during stasis" EMBO J. 15: 3219-3228 (1996)					
M	Database WPI, Section Ch WP01/02544A (11 Jan 20	01)				
W-	Database WPI, Section Ch, Week 200114, Derwent Pub, London, Class B05, AN 2001-138135, XP002260036 & WO01/02546A (11 Jan 2001)					

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ATTY DOCKET NO. SERIAL NO. U.S. DEPAREMENT OF COMMERCE PATENT AND PRADEMARK OFFICE Form PTO 1449 (Modified) 239798US0 10/613,990 APPLICANT LIST OF REFERENCES CITED BY APPLICANT Yukiko ISHIKAWA, et al. FILING DATE **GROUP** July 8, 2003 U.S. PATENT DOCUMENTS FILING DATE **EXAMINER DOCUMENT** SUB DATE NAME CLASS **CLASS** IF APPROPRIATE INITIAL NUMBER AA AB AC AD ΑE AF AG AΗ ΑI AJ ΑK AL AM AN **FOREIGN PATENT DOCUMENTS TRANSLATION** DOCUMENT DATE COUNTRY NUMBER YES AO AP AQ AR AS AT ΑU ΑV OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.) S. IUCHI, et al., Cell, Minireview, vol. 66, pages 5-7, "ADAPTATION OF ESCHERICHIA COLI TO RESPIRATORY CONDITIONS: REGULATION OF GENE EXPRESSION", July 12, 1991 F. R. BLATTNER, et al., Science, vol. 277, pages 1453-1462, "THE COMPLETE GENOME SEQUENCE OF ESCHERICHIA COLI K-12", September 5, 1997 ΑX ΑY ΑZ Additional References sheet(s) attached **Date Considered** Examiner, *Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.